

SEMITRANS® 3

Trench IGBT Modules

SKM600GAR07E3

Features*

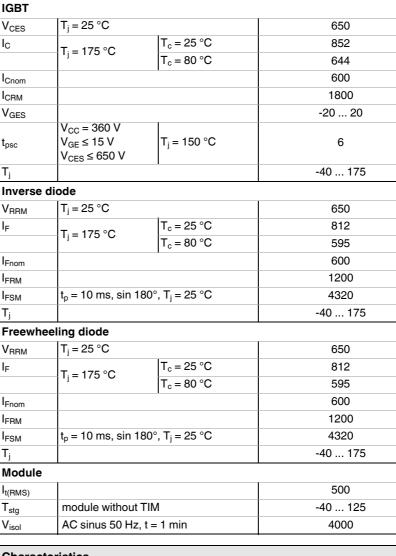
- V_{CE(sat)} with positive temperature coefficient
- · High short circuit capability, self limiting to 6 x I_{cnom}
- · Fast & soft switching inverse CAL diodes
- Insulated copper baseplate using DCB Technology (Direct Copper Bonding)
- · With integrated gate resistor

Typical Applications

- · Electronic welders
- DC/DC converter
- · Brake chopper
- · Switched reluctance motor

Remarks

- · Case temperature limited to $T_c = 125^{\circ}C$ max.
- Recommended T_{op} = -40 ... +150°C
- · Product reliability results valid for $T_i = 150$ °C
- · Use of soft R_G necessary



Values

Unit

٧

Α

Α

Α

Α

V

μs

°C

٧

Α

Α

Α

Α

Α

°С

Α

Α

Α

Α

Α

°C

Α

°C

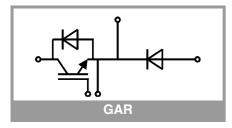
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Absolute Maximum Ratings

Conditions

Symbol

Characte	ristics					
Symbol	Conditions	min.	typ.	max.	Unit	
IGBT						
V _{CE(sat)}	$I_{\rm C} = 600 {\rm A}$	T _j = 25 °C		1.45	1.90	V
-	V _{GE} = 15 V chiplevel	T _j = 150 °C		1.70	2.10	V
V _{CE0}	chiplevel	T _j = 25 °C		0.90	1.00	V
		T _j = 150 °C		0.82	0.90	V
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		0.92	1.50	mΩ
	chiplevel	T _j = 150 °C		1.47	2.00	mΩ
$V_{\text{GE(th)}}$	$V_{GE}=V_{CE}$, $I_{C}=9.6$ mA		5.1	5.8	6.4	V
I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 650 \text{ V}, T_j = 25 ^{\circ}\text{C}$				0.3	mA
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		37.0		nF
C _{oes}		f = 1 MHz		2.32		nF
C _{res}		f = 1 MHz		1.10		nF
Q_G	V _{GE} = - 8 V+ 15 V			4800		nC
R _{Gint}	T _j = 25 °C			0.5		Ω





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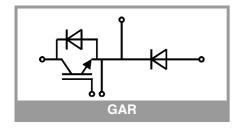
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Characte	ristics					
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
t _{d(on)}	V _{CC} = 300 V	T _j = 150 °C		83		ns
t _r	$I_{\rm C} = 600 {\rm A}$	T _j = 150 °C		121		ns
E _{on}	$V_{GE} = +15/-7.5 \text{ V}$ $R_{G \text{ on}} = 3 \Omega$	T _j = 150 °C		20		mJ
t _{d(off)}	$R_{G \text{ off}} = 4.3 \Omega$	T _j = 150 °C		1100		ns
t _f	$di/dt_{on} = 4900 \text{ A/}\mu\text{s}$	T _j = 150 °C		93		ns
E _{off}	di/dt_{off} = 6700 A/µs dv/dt = 1330 V/µs L_s = 20 nH	T _j = 150 °C		37		mJ
R _{th(j-c)}	per IGBT				0.066	K/W
R _{th(c-s)}	per IGBT (λ _{grease} =0.81 W/(m*K))			0.033		K/W
R _{th(c-s)}	per IGBT, pre-applied phase change material			0.02		K/W
Inverse di	ode					
$V_F = V_{EC}$	I _F = 600 A	T _j = 25 °C		1.40	1.76	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		1.38	1.77	V
V _{F0}		T _i = 25 °C		1.04	1.24	V
	chiplevel	T _j = 150 °C		0.85	0.99	V
r _F chiplevel	chinloyel	T _j = 25 °C		0.60	0.88	mΩ
	cnipievei	T _j = 150 °C		0.89	1.31	mΩ
I _{RRM}	I _F = 600 A	T _j = 150 °C		390		Α
Q _{rr}	$di/dt_{off} = 4940 \text{ A/}\mu\text{s}$ $V_{GE} = -7.5 \text{ V}$	T _j = 150 °C		54		μC
E _{rr}	$V_{CC} = 300 \text{ V}$	T _j = 150 °C		9.1		mJ
R _{th(j-c)}	per diode				0.096	K/W
R _{th(c-s)}	per diode (λ _{grease} =0.81 W/(m*K))			0.038		K/W
R _{th(c-s)}	per diode, pre-applied phase change material			0.028		K/W
Freewhee	ling diode					
$V_F = V_{EC}$	I _F = 600 A	T _j = 25 °C		1.40	1.76	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		1.38	1.77	٧
V _{F0}		T _j = 25 °C		1.04	1.24	V
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E _{rr}	$V_{GE} = -7.5 \text{ V}$ $V_{CC} = 300 \text{ V}$	T _j = 150 °C		9.1		mJ
R _{th(j-c)}	per diode	<u>I</u>			0.096	K/W
R _{th(c-s)}	per diode (λ _{grease} =0.81 W/(m*K))			0.038		K/W
R _{th(c-s)}	per diode, pre-applied phase change material			0.028		K/W





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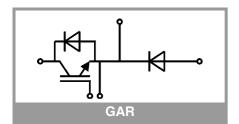
Typical Applications

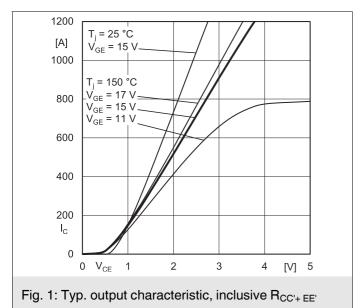
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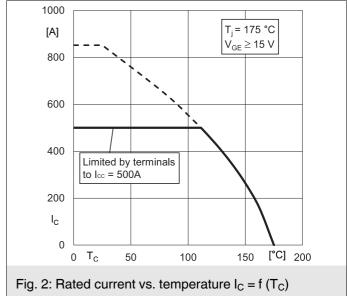
Remarks

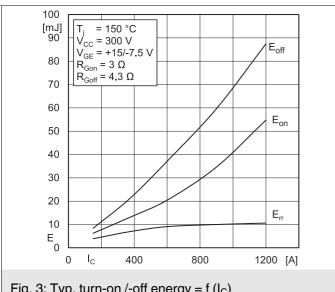
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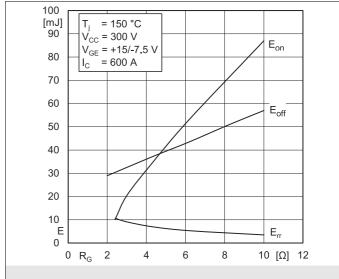
Characte	eristics					
Symbol	Conditions		min.	typ.	max.	Unit
Module			•			•
L _{CE}				15		nΗ
R _{CC'+EE'}	measured per switch	T _C = 25 °C		0.55	mΩ	
		T _C = 125 °C		0.85		mΩ
R _{th(c-s)1}	calculated without thermal coupling			0.0177		K/W
R _{th(c-s)2}	including thermal coupling, T _s underneath module (\(\lambda_{\text{grease}} = 0.81 \) W/(m*K))		0.018			K/W
R _{th(c-s)2}	including thermal coupling, T _s underneath module, pre-applied phase change material			0.012		K/W
Ms	to heat sink M6		3		5	Nm
M _t		to terminals M6	2.5		5	Nm
						Nm
W		•			325	g

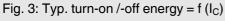


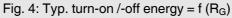


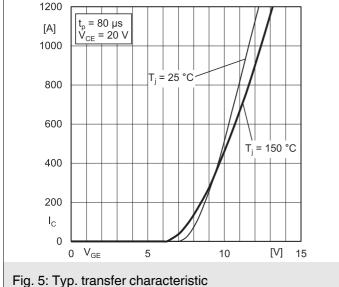


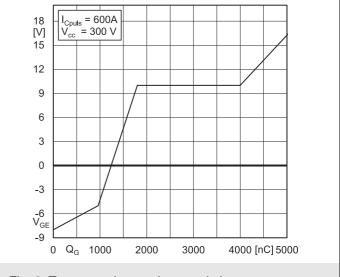


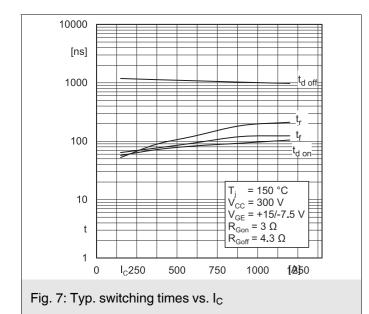


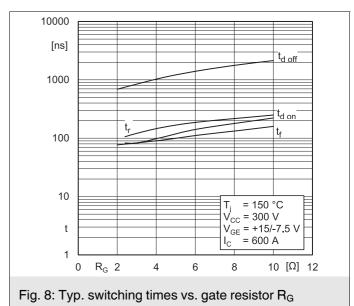


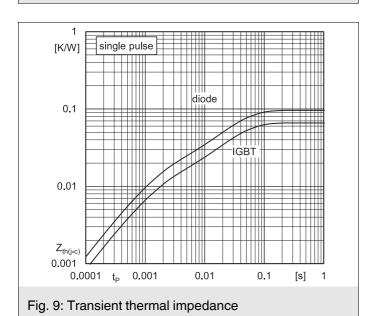


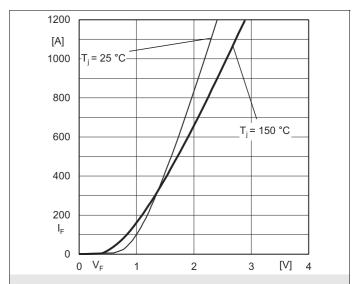












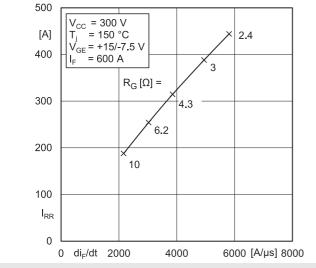


Fig. 10: Typ. CAL diode forward charact., incl. $R_{\text{CC}'\text{+ EE'}}$



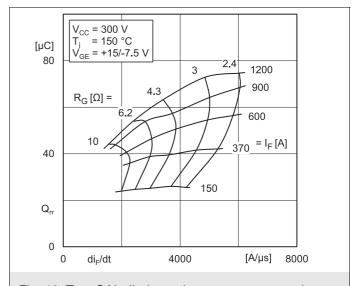
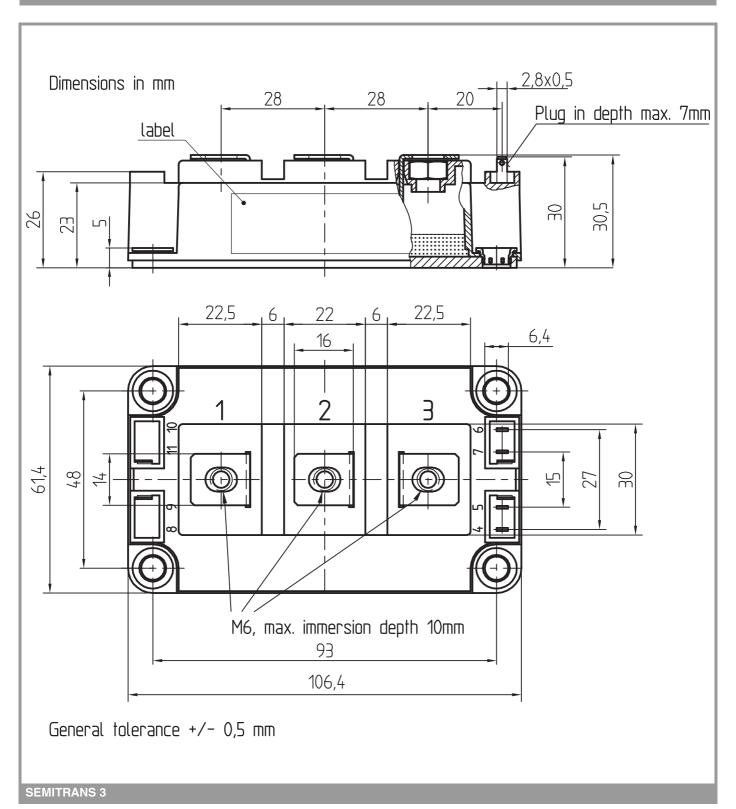
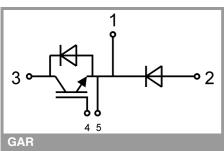


Fig. 12: Typ. CAL diode peak reverse recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, chapter IX.

*IMPORTANT INFORMATION AND WARNINGS

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